TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type

## SSM3K104TU

Power Management Switch Applications High-Speed Switching Applications

- 1.8 V drive
- Low ON-resistance:  $R_{on}$  = 110 m $\Omega$  (max) (@V<sub>GS</sub> = 1.8 V)

 $R_{on} = 74 \text{ m}\Omega \text{ (max)} (@V_{GS} = 2.5 \text{ V})$ 

 $R_{on} = 56 \text{ m}\Omega \text{ (max)} (@V_{GS} = 4.0 \text{ V})$ 

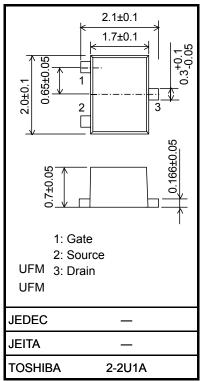
#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V <sub>DS</sub>	20	V	
Gate-Source voltage		V <sub>GSS</sub>	± 12	V	
Drain current	DC	I <sub>D</sub>	3.0	A	
	Pulse	I <sub>DP</sub>	6.0		
Drain power dissipation		PD (Note 1)	800	mW	
		PD (Note 2)	500		
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure

rate, etc). Note 1: Mounted on a ceramic board. (25.4 mm  $\times$  25.4 mm  $\times$  0.8 t, Cu Pad: 645 mm<sup>2</sup> )

#### Electrical Characteristics (Ta = 25°C)



Weight: 6.6 mg (typ.)

Charact	eristics	Symbol	Test Condition	า	Min	Тур.	Мах	Unit
Drain-Source breakdown voltage		V (BR) DSS	$V_{(BR) DSS}$ $I_D = 1 \text{ mA}, V_{GS} = 0$		20	_		V
		V (BR) DSX	$I_D = 1 \text{ mA}, V_{GS} = -12 \text{ V}$	12		_		
Drain cutoff curren	t	I <sub>DSS</sub>	$V_{DS} = 20 V, V_{GS} = 0$			_	1	μA
Gate leakage curre	ent	I <sub>GSS</sub>	$V_{GS}=\pm 12~V,~V_{DS}=0$		_		±1	μA
Gate threshold vol	tage	V <sub>th</sub>	$V_{DS} = 3 V, I_D = 1 mA$		0.4		1.0	V
Forward transfer a	dmittance	Y <sub>fs</sub>	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 2.0 \text{ A}$	(Note 3)	6	10	_	S
Drain-Source ON-resistance		R <sub>DS</sub> (ON)	$I_D = 2.0 \text{ A}, V_{GS} = 4.0 \text{ V}$	(Note 3)	_	44	56	mΩ
			$I_D = 1.0 \text{ A}, V_{GS} = 2.5 \text{ V}$	(Note 3)	_	53	74	
			$I_D = 0.5 \text{ A}, V_{GS} = 1.8 \text{ V}$	(Note 3)		70	110	
Input capacitance		C <sub>iss</sub>	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ f}$	MHz	_	320	_	pF
Output capacitance		C <sub>oss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		_	62	_	pF
Reverse transfer c	apacitance	C <sub>rss</sub>	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ N}$	MHz		51		pF
Switching time	Turn-on time	t <sub>on</sub>	$V_{DD}$ = 10 V, I <sub>D</sub> = 2 A, V <sub>GS</sub> = 0~2.5 V, R <sub>G</sub> = 4.7 Ω			18		ns
	Turn-off time	t <sub>off</sub>			_	14	_	
Drain-Source forwa	ard voltage	V <sub>DSF</sub>	$I_D = -3.0 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$	(Note 3)	_	-0.85	-1.2	V

Note 3: Pulse test

Unit: mm

Note 2: Mounted on an FR4 board. (25.4 mm  $\times$  25.4 mm  $\times$  1.6 t, Cu Pad: 645 mm<sup>2</sup>)

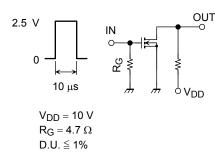
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#### **Switching Time Test Circuit**

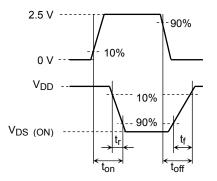
 $V_{IN}\text{: }t_{r}\text{, }t_{f}<5\text{ ns}$ Common Source  $Ta = 25^{\circ}C$ 

#### (a) Test Circuit

(b) V<sub>IN</sub>

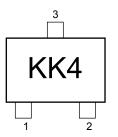






#### Marking

#### Equivalent Circuit (top view)



# 3

#### Notice on Usage

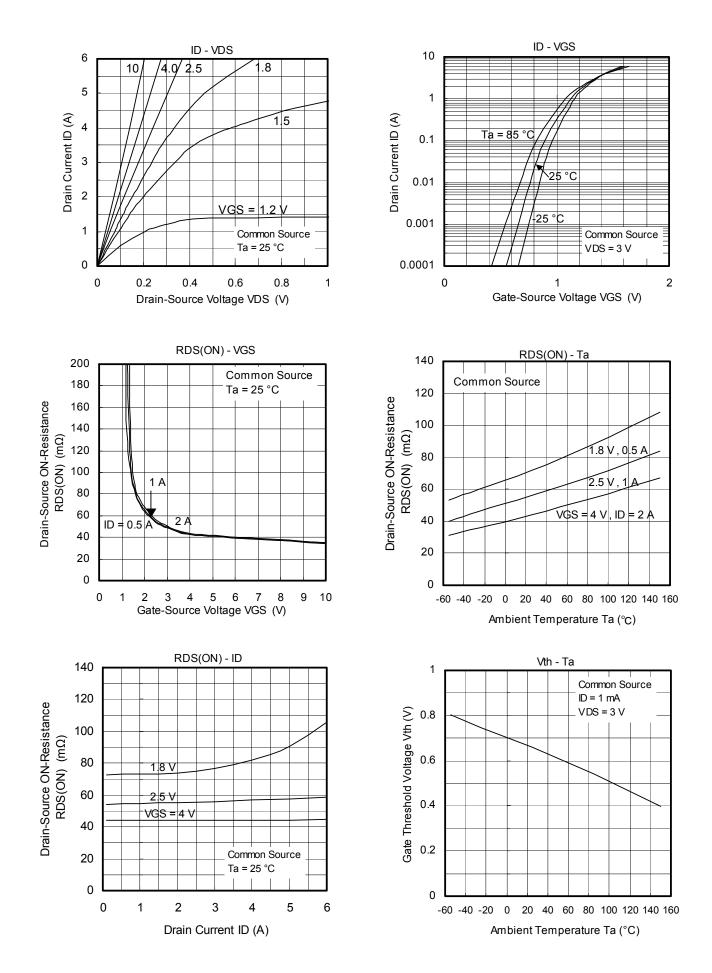
Vth can be expressed as the voltage between gate and source when the low operating current value is ID = 1 mA for this product. For normal switching operation, VGS (on) requires a higher voltage than Vth, and VGS (off) requires a lower voltage than V<sub>th.</sub> (The relationship can be established as follows: V<sub>GS (off)</sub> < V<sub>th</sub> < V<sub>GS (on).</sub>)

Take this into consideration when using the device.

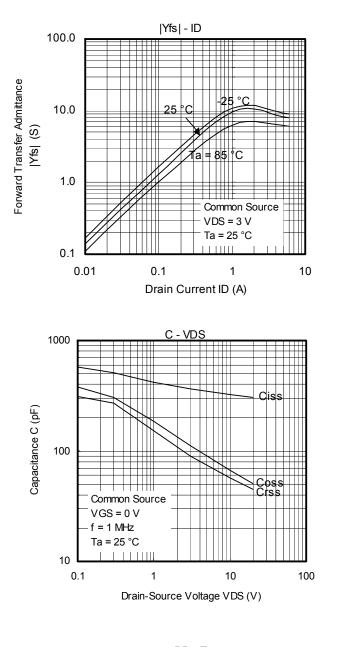
#### **Handling Precaution**

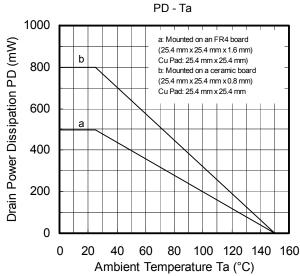
When handling individual devices that are not yet mounted on a circuit board, make sure that the environment is protected against electrostatic discharge. Operators should wear antistatic clothing, and containers and other objects that come into direct contact with devices should be made of antistatic materials.

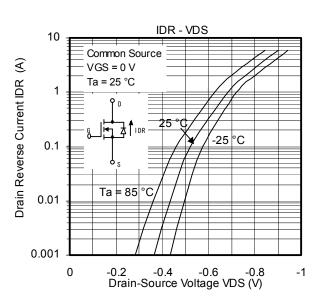
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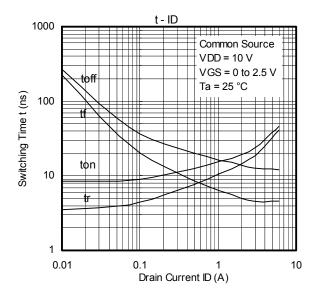


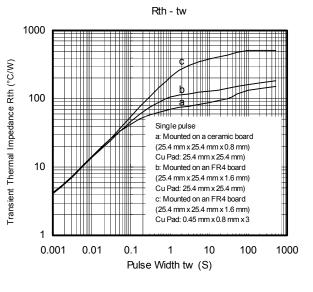
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20070701-EN GENERAL

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